Search Notes



plication/Control No.	Applicant(s)/Patent under Reexamination
/564.240	LEE, KWANGSOO

Aр

SEARCHED				
Class	Subclass	Date	Examiner	
036	029			
	3B,3R	2/23/2008	/TK/	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	
Int. sean	ch printout	2/23/2008	/TK/	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	